Applicant(s)/Patent Under Application/Control No. Reexamination 09/480,861 YONEZAWA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2621 Shawn S. An **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 08-2001 Vaios, Christos I. 340/541 US-6,271,752 B1 Α US-В US-С US-D US-Ε US-F US-G Н US-US-1 US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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